

<b>Notice of References Cited</b>			Application/Control No.	Applicant(s)/Patent Under Reexamination FUJII ET AL.	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
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	C	US-			
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	K	US-			
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**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
*	N	EP 1153595 A2	11-2001	European Patent	SHIROYAMA et al.	
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**NON-PATENT DOCUMENTS**

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